

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10564164	MIYAJI ET AL.
	Examiner	Art Unit
	Tran Nguyen	2834

SEARCHED

Class	Subclass	Date	Examiner
310	64, 6868D	4/12/08	/TN/
363	123, 125, 126, 144, 145	4/12/08	/TN/

SEARCH NOTES

Search Notes	Date	Examiner

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner